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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No	09/783,377
Filing Date	February 13, 200 <i>°</i>
Inventor	
Assignee	
Group Art Unit	•
Examiner	Combs, Janell A
Attorney's Docket No	30-5022 (4015
Title: Methods of Forming Aluminum-Comprising Physica	I Vapor Deposition Targets;
Sputtered Films; and Target Constructions	

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

To:

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

From:

Jennifer J. Taylor, Ph.D. (Tel. 509-624-4276; Fax 509-838-3424)

Wells St. John P.S.

601 W. First Avenue, Suite 1300

Spokane, WA 99201-3828

Dear Sir:

The Examiner's attention is directed to the references which are listed on the attached Form PTO-1449 and copies of which are attached.

Citation of these references is respectfully requested.

Respectfully submitted,

Dated:

Bv:

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ΑΓΙΥ. DOCKET NO. 30-5022(4015)

SERIAL'NO. 09/783,377

LIST OF ART CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT Vladimir Segal et al. FILING DATE February 13, 2001

GROUP 1742

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate				
	AA	5,850,755	12-1998	Segal et al.							
	AB						 				
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		Document Number	Date	Country	Class	Subclass	Translation				
					-		Yes	No			
	AF AG										
	AH										
	AI										
<u> </u>	, AJ										
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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. 30-5004(4015)

SERIAL NO. 09/465,492

LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)

FILING DATE December 16, 1999

APPLICANT Vladimir Segal et al.

GROUP 1742

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